Three Level NPC Q2Pack Module

NXH350N100H4Q2F2

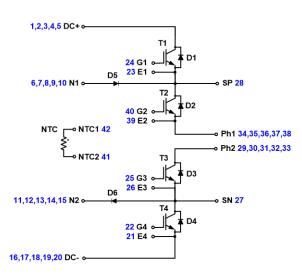
This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

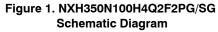
Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Low Package Height
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies Systems



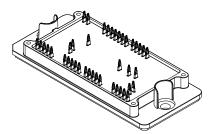




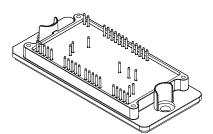
ON Semiconductor®

www.onsemi.com

PACKAGE PICTURE

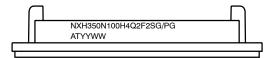


Q2PACK INPC PRESS FIT PINS CASE 180BH



Q2PACK INPC SOLDER PINS CASE 180BS

MARKING DIAGRAM



G = Pb-Free Package

AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

PIN CONNECTIONS

See details pin connections on page 2 of this data sheet.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

PIN CONNECTIONS

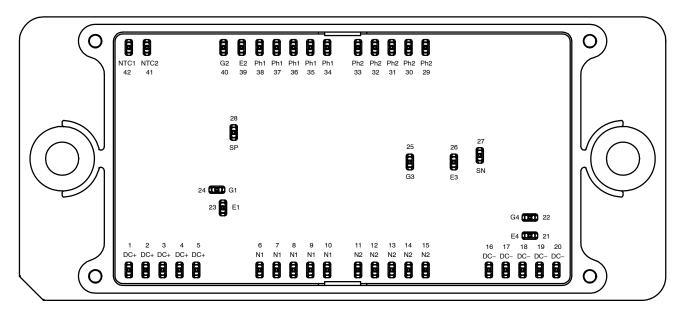


Figure 2. Pin Connections

ABSOLUTE MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Rating	Symbol	Value	Unit
OUTER IGBT (T1, T4)			
Collector-Emitter Voltage	V _{CES}	1000	V
Gate-Emitter Voltage Positive transient gate-emitter voltage (T _{pulse} = 5 μs, D < 0.10)	V _{GE}	±20 30	V
Continuous Collector Current @ $T_C = 80^{\circ}C$	Ι _C	303	А
Pulsed Peak Collector Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	I _{C(Pulse)}	909	А
Maximum Power Dissipation ($T_J = 150^{\circ}C$)	P _{tot}	592	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature (Note 2)	T _{JMAX}	150	°C
INNER IGBT (T2, T3)	· ·		
Collector-Emitter Voltage	V _{CES}	1000	V
Gate-Emitter Voltage Positive transient gate-emitter voltage ($T_{pulse} = 5 \ \mu s$, D < 0.10)	V _{GE}	±20 30	V
Continuous Collector Current @ $T_C = 80^{\circ}C$	Ι _C	329	А
Pulsed Peak Collector Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	I _{C(Pulse)}	987	А
Maximum Power Dissipation ($T_J = 175^{\circ}C$)	P _{tot}	532	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature (Note 2)	T _{JMAX}	150	°C
IGBT INVERSE DIODE (D1, D2, D3, D4)			
Peak Repetitive Reverse Voltage	V _{RRM}	1000	V
Continuous Forward Current @ T_C = 80°C	IF	133	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	399	А
Maximum Power Dissipation ($T_J = 175^{\circ}C$)	P _{tot}	276	W

ABSOLUTE MAXIMUM RATINGS (T₁ = 25°C unless otherwise noted) (continued)

Rating	Symbol	Value	Unit
IGBT INVERSE DIODE (D1, D2, D3, D4)	_		
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
NEUTRAL POINT DIODE (D5, D6)			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ $T_C = 80^{\circ}C$	١ _F	98	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	294	А
Maximum Power Dissipation ($T_J = 175^{\circ}C$)	P _{tot}	239	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
THERMAL PROPERTIES			
Operating Temperature under Switching Condition	T _{VJOP}	-40 to +150	°C
Storage Temperature Range	T _{stg}	-40 to +125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 2 s, 50 Hz (Note 3)	V _{is}	4000	V _{RM}
Creepage Distance		12.7	mm
Comparative Tracking Index	CTI	> 600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS and/or APPLICATION INFORMATION for Safe Operating parameters.

2. Qualification at 175°C per discrete TO247.

3. 4000 VAC_{RMS} for 1 second duration is equivalent to 3333 VAC_{RMS} for 1 minute duration.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTER	RISTICS					
Collector-Emitter Cutoff Current	$V_{GE} = 0 \text{ V}, \text{ V}_{CE} = 1000 \text{ V}$	I _{CES}	—	-	1000	μΑ
Collector-Emitter Saturation Voltage	V_{GE} = 15 V, I _C = 375 A, T _J = 25°C	V _{CE(sat)}	_	1.63	1.80	V
	V_{GE} = 15 V, I _C = 375 A, T _J = 150°C		_	1.92	-	
Gate-Emitter Threshold Voltage	V_{GE} = V_{CE} , I_C = 375 mA	V _{GE(TH)}	4.1	4.84	5.7	V
Gate Leakage Current	V_{GE} = ±20 V, V_{CE} = 0 V	I _{GES}	_	_	±2000	nA
Turn-on Delay Time	$T_J = 25$ °C V _{CE} = 600 V, I _C = 170 A V _{GE} = -8 V, 15 V, R _G = 5 Ω	t _{d(on)}	_	86	-	ns
Rise Time		t _r	_	30	-	
Turn-off Delay Time		t _{d(off)}	_	312	-	
Fall Time		t _f	_	32	-	
Turn-on Switching Loss per Pulse		E _{on}	_	2376	-	μJ
Turn-off Switching Loss per Pulse		E _{off}	_	5437	-	
Turn-on Delay Time	T _J = 125°C	t _{d(on)}	_	79	-	ns
Rise Time	V _{CE} = 600 V, I _C = 170 A V _{GE} = -8 V, 15 V, R _G = 5 Ω	t _r	_	35	-	
Turn-off Delay Time		t _{d(off)}	_	357	-	
Fall Time		t _f	_	73	-	
Turn-on Switching Loss per Pulse		Eon	—	4568	-	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	7421	_	

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTER	RISTICS	-				
Input Capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{ies}	_	24146	_	pF
Output Capacitance	1	C _{oes}	_	1027	_	
Reverse Transfer Capacitance	1	C _{res}	-	106	_	
Total Gate Charge	V_{CE} = 600 V, I _C = 375 A, V _{GE} = 15 V	Qg	—	680	_	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJH}	-	0.22	-	K/W
Thermal Resistance – Chip-to-Case	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	0.12	-	K/W
NEUTRAL POINT DIODE (D5, D6) (CHARACTERISTICS					
Diode Forward Voltage	$I_F = 100 \text{ A}, T_J = 25^{\circ}\text{C}$	V _F	-	1.50	1.85	V
	$I_F = 100 \text{ A}, \text{T}_\text{J} = 150^\circ\text{C}$		-	2.07	-	
Reverse Recovery Time	$T_{\rm J} = 25^{\circ}{\rm C}$	t _{rr}	-	19	-	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 170 A V _{GE} = –8 V, 15 V, R _G = 5 Ω	Q _{rr}	_	229	-	μC
Peak Reverse Recovery Current		I _{RRM}	-	19		А
Peak Rate of Fall of Recovery Current		di/dt	_	6053	—	A/μs
Reverse Recovery Energy	1	E _{rr}	-	164	-	μJ
Reverse Recovery Time	$T_{\rm J} = 125^{\circ}C$	t _{rr}	-	34	_	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 120 A V _{GE} = –8 V, 15 V, R _G = 5 Ω	Q _{rr}	-	359	_	μC
Peak Reverse Recovery Current		I _{RRM}	-	17	-	А
Peak Rate of Fall of Recovery Current		di/dt	_	4621	_	A/μs
Reverse Recovery Energy	1	E _{rr}	—	211	-	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJH}	_	0.42	_	K/W
Thermal Resistance – Chip-to-Case	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	0.29		K/W
INNER IGBT (T2, T3) CHARACTER	ISTICS					
Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1000 V	I _{CES}	-	-	500	μA
Collector-Emitter Saturation Voltage	V_{GE} = 15 V, I _C = 300 A, T _J = 25°C	V _{CE(sat)}	—	1.27	1.50	V
	V_{GE} = 15 V, I_C = 300 A, T_J = 150°C		-	1.34	-	
Gate-Emitter Threshold Voltage	V_{GE} = V_{CE} , I_C = 300 mA	V _{GE(TH)}	4.1	4.96	5.7	V
Gate Leakage Current	V_{GE} = ±20 V, V_{CE} = 0 V	I _{GES}	_	_	±1600	nA
Turn-on Delay Time	T _J = 25°C V _{CE} = 600 V, I _C = 170 A	t _{d(on)}	-	69.5	-	ns
Rise Time	$V_{GE} = -8 V, 15 V, R_{G} = 5 \Omega$	t _r	—	31	-	
Turn-off Delay Time	1	t _{d(off)}	_	422.5	_	
Fall Time	1	t _f	_	51.5	_	
Turn-on Switching Loss per Pulse	1	E _{on}	_	3705	_	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	_	12590		
Turn-on Delay Time	T _J = 125°C V _{CE} = 600 V, I _C = 170 A	t _{d(on)}	_	66		ns
Rise Time	$V_{GE} = 800$ V, $1_{C} = 170$ A $V_{GE} = -8$ V, 15 V, $R_{G} = 5 \Omega$	t _r	-	30.5	-	
Turn-off Delay Time	1	t _{d(off)}	_	508.5	_	
Fall Time	1	t _f	_	64	_	
Turn-on Switching Loss per Pulse	1	E _{on}	_	5777	_	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	_	18390	_	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
INNER IGBT (T2, T3) CHARACTERISTICS						
Input Capacitance	V_{CE} = 20 V, V_{GE} = 0 V, f = 1 MHz	C _{ies}	-	25260	-	pF
Output Capacitance		C _{oes}	-	1009	-	
Reverse Transfer Capacitance		C _{res}	-	118	_	
Total Gate Charge	V_{CE} = 600 V, I_C = 300 A, V_{GE} = 15 V	Qg	-	720	-	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJH}	-	0.24	-	K/W
Thermal Resistance – Chip-to-Case	λ = 2.9 W/mK	R _{thJC}	_	0.13		K/W

IGBT INVERSE DIODE (D1, D2, D3, D4) CHARACTERISTICS

Diode Forward Voltage	$I_F = 150 \text{ A}, T_J = 25^{\circ}\text{C}$	V _F	—	2.06	2.44	V
	I _F = 150 A, T _J = 150°C	1	-	1.77	_	
Reverse Recovery Time	T _J = 25°C	t _{rr}	-	96	-	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 170 A V _{GE} = –8 V, 15 V, R _G = 5 Ω	Q _{rr}	-	5094	_	μC
Peak Reverse Recovery Current		I _{RRM}	-	124	-	А
Peak Rate of Fall of Recovery Current		di/dt	-	4571	-	A/μs
Reverse Recovery Energy		E _{rr}	_	2069	-	μJ
Reverse Recovery Time	T _J = 125°C	t _{rr}	-	192	_	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 170 A V _{GE} = –8 V, 15 V, R _G = 5 Ω	Q _{rr}	-	11900	_	μC
Peak Reverse Recovery Current		I _{RRM}	-	148	_	А
Peak Rate of Fall of Recovery Current		di/dt	-	4167	_	A/μs
Reverse Recovery Energy		Err	_	4665	_	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ λ = 2.9 W/mK	R _{thJH}	-	0.39	_	K/W
Thermal Resistance - Chip-to-Case		R _{thJC}	-	0.25	-	K/W

THERMISTOR CHARACTERISTICS

Nominal Resistance	T = 25°C	R ₂₅	—	22	—	kΩ
Nominal Resistance	T = 100°C	R ₁₀₀	_	1486	_	kΩ
Deviation of R25		$\Delta R/R$	-5	_	5	%
Power Dissipation		PD	-	200	-	mW
Power Dissipation Constant			-	2	-	mW/K
B-value	B(25/50), tolerance ±3%		-	3950	-	К
B-value	B(25/100), tolerance ±3%		_	3998	_	К

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping
NXH350N100H4Q2F2PG PRESS FIT PINS	NXH350N100H4Q2F2PG	Q2PACK (Pb-free/Halide-free)	12 Units / Blister Tray
NXH350N100H4Q2F2SG SOLDER PINS	NXH350N100H4Q2F2SG	Q2PACK (Pb-free/Halide-free)	12 Units / Blister Tray

TYPICAL CHARACTERISTICS – OUTER IGBT, INNER IGBT

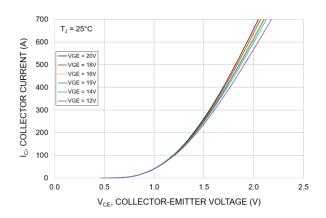


Figure 3. Typical Output Characteristics – Outer IGBT

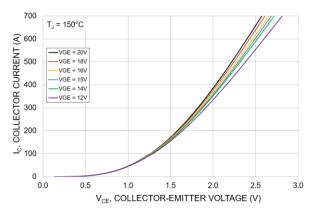


Figure 4. Typical Output Characteristics – Outer IGBT

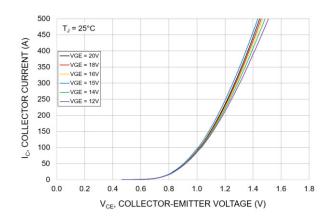


Figure 5. Typical Output Characteristics – Inner IGBT

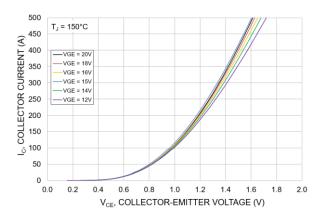


Figure 6. Typical Output Characteristics – Inner IGBT

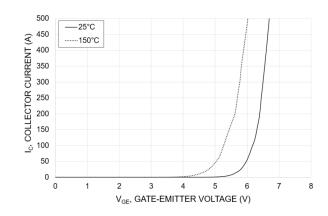


Figure 8. Transfer Characteristics – Inner IGBT

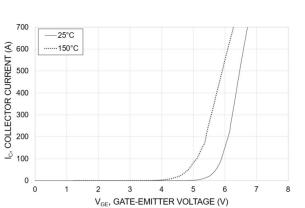
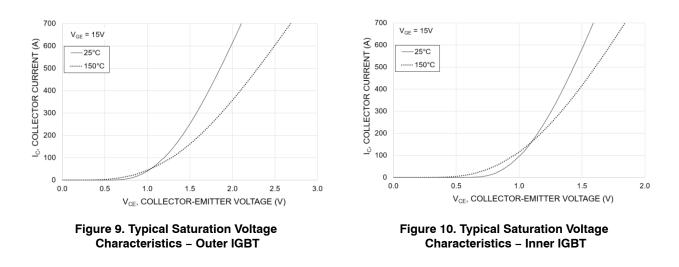


Figure 7. Transfer Characteristics – Outer IGBT

TYPICAL CHARACTERISTICS – OUTER IGBT, INNER IGBT, IGBT INVERSE DIODE AND NEUTRAL POINT DIODE



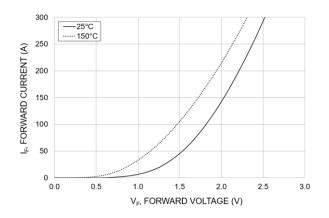


Figure 11. Inverse Diode Forward Characteristics

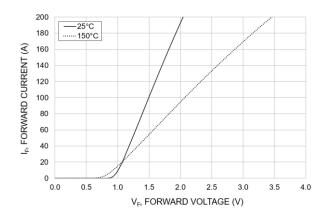


Figure 12. Buck Diode Forward Characteristics

TYPICAL SWITCHING CHARACTERISTICS – OUTER IGBT

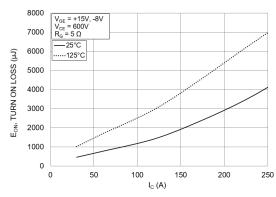


Figure 13. Typical Turn On Loss vs. IC

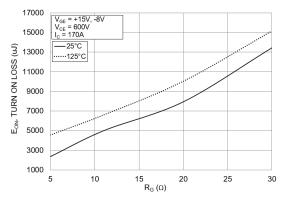


Figure 15. Typical Turn On Loss vs. R_G

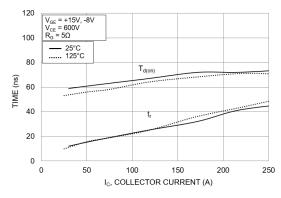


Figure 17. Typical Turn On Switching Time vs. IC

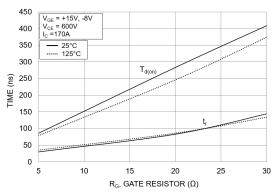


Figure 19. Typical Turn On Switching Time vs. R_G

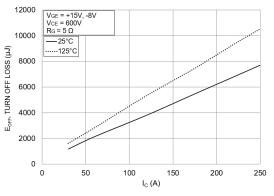


Figure 14. Typical Turn Off Loss vs. IC

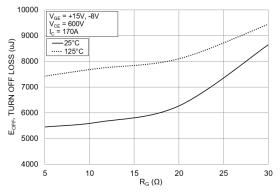


Figure 16. Typical Turn Off Loss vs. R_G

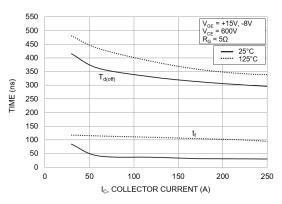


Figure 18. Typical Turn Off Switching Time vs. $\rm I_{C}$

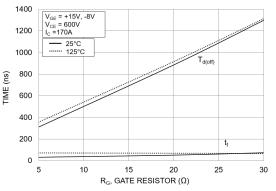


Figure 20. Typical Turn On Switching Time vs. R_G

TYPICAL SWITCHING CHARACTERISTICS – INNER IGBT

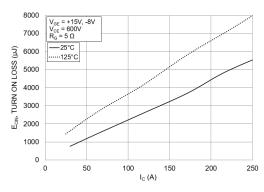


Figure 21. Typical Turn On Loss vs. I_C

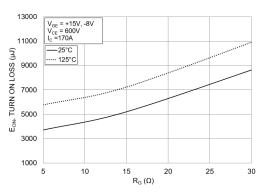


Figure 23. Typical Turn On Loss vs. R_G

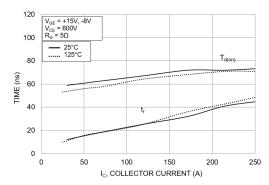


Figure 25. Typical Turn On Switching Time vs. I_C

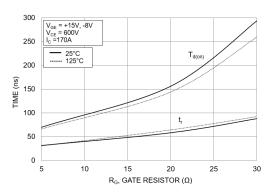


Figure 27. Typical Turn On Switching Time vs. $\rm R_{G}$

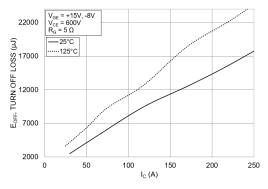


Figure 22. Typical Turn Off Loss vs. $\rm I_C$

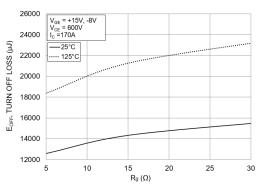


Figure 24. Typical Turn Off Loss vs. $\rm R_{G}$

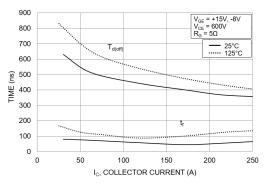


Figure 26. Typical Turn Off Switching Time vs. $\rm I_{C}$

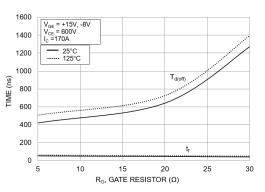
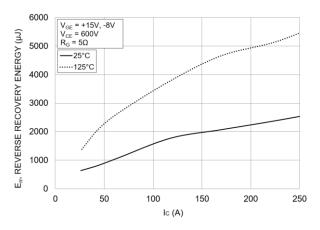
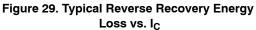


Figure 28. Typical Turn On Switching Time vs. ${\rm R}_{\rm G}$

TYPICAL SWITCHING CHARACTERISTICS – INVERSE DIODE

5000





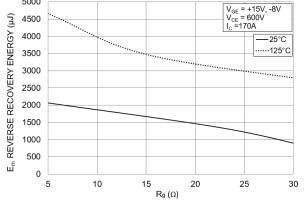


Figure 30. Typical Reverse Recovery Energy Loss vs. R_G

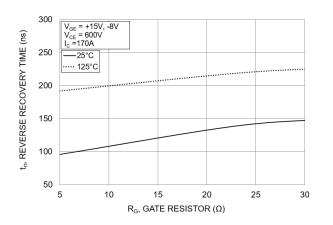


Figure 31. Typical Reverse Recovery Time vs. R_G

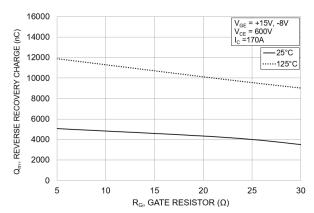
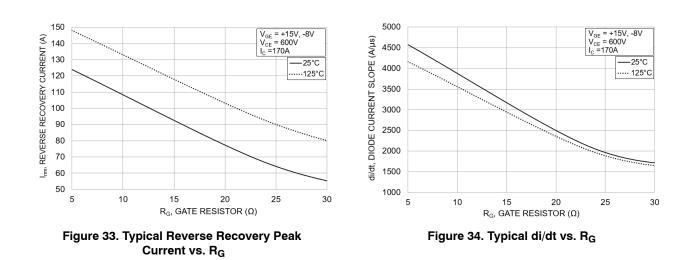


Figure 32. Typical Reverse Recovery Charge vs. R_G



TYPICAL SWITCHING CHARACTERISTICS – NEUTRAL POINT DIODE

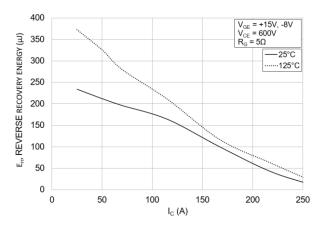


Figure 35. Typical Reverse Recovery Energy Loss vs. I_C

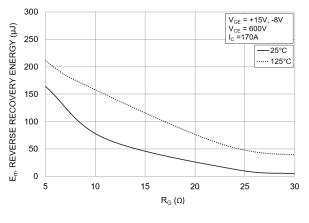


Figure 36. Typical Reverse Recovery Energy Loss vs. R_G

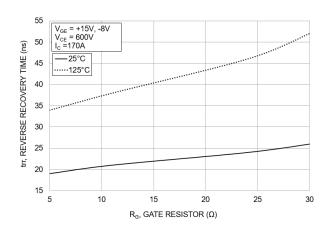


Figure 37. Typical Reverse Recovery Time vs. R_G

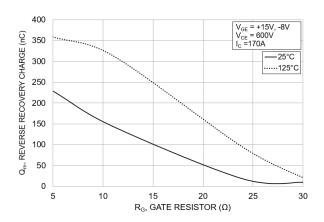
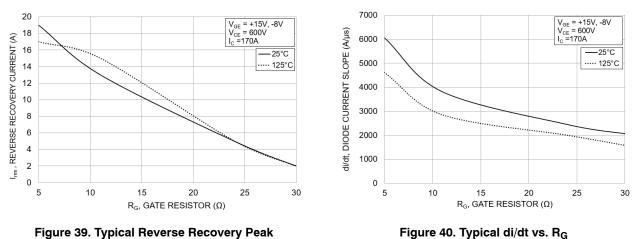


Figure 38. Typical Reverse Recovery Charge vs. R_G



Current vs. R_G

TRANSIENT THERMAL IMPEDANCE

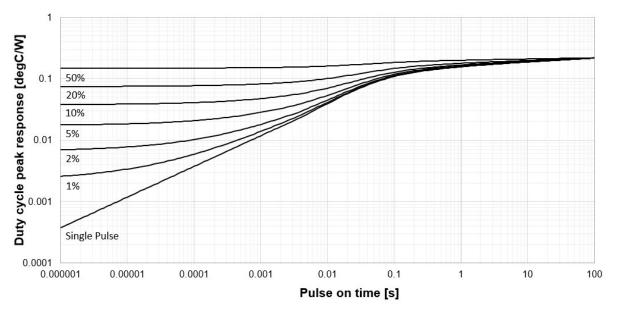


Figure 41. Transient Thermal Impedance – Outer IGBT

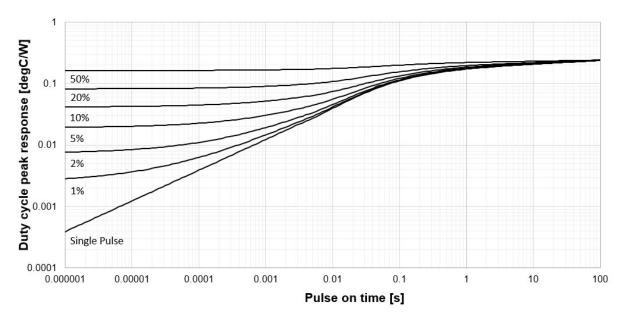


Figure 42. Transient Thermal Impedance – Inner IGBT

TRANSIENT THERMAL IMPEDANCE (Continued)

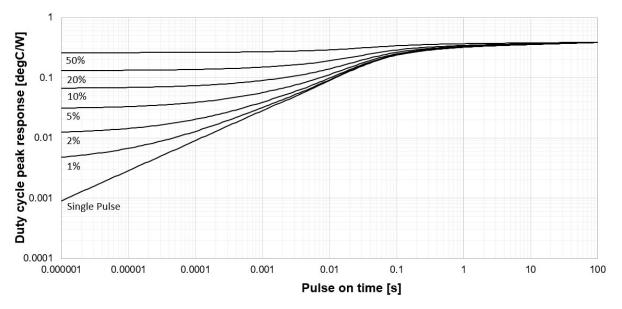


Figure 43. Transient Thermal Impedance – Inverse Diode

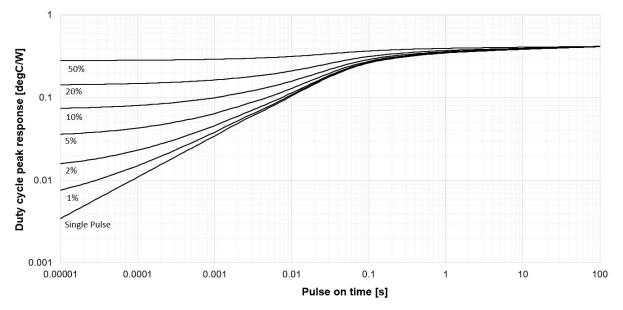


Figure 44. Transient Thermal Impedance – Neutral Point Diode

SAFE OPERATING AREA

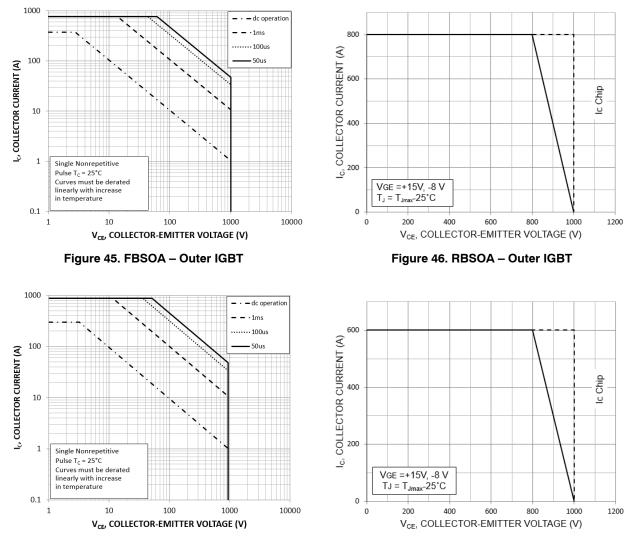
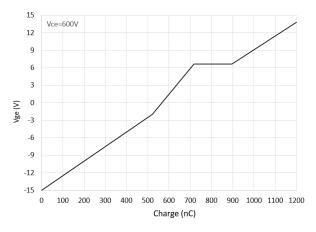
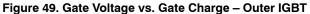




Figure 48. RBSOA – Inner IGBT

GATE CHARGE AND CAPACITANCE





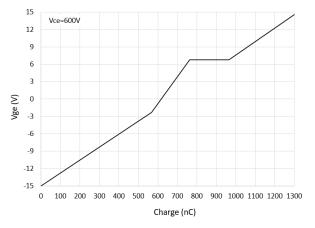


Figure 50. Gate Voltage vs. Gate Charge – Inner IGBT

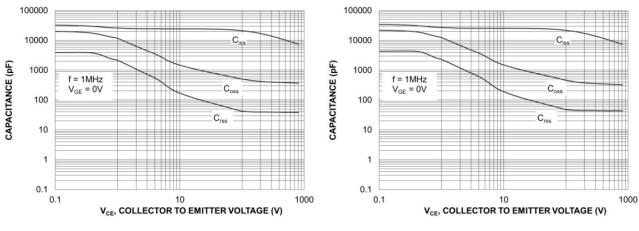
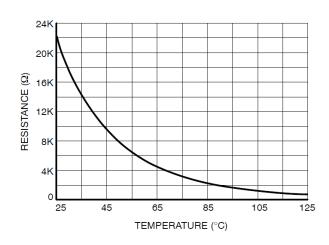


Figure 51. Capacitance Charge – Outer IGBT

Figure 52. Capacitance Charge – Inner IGBT

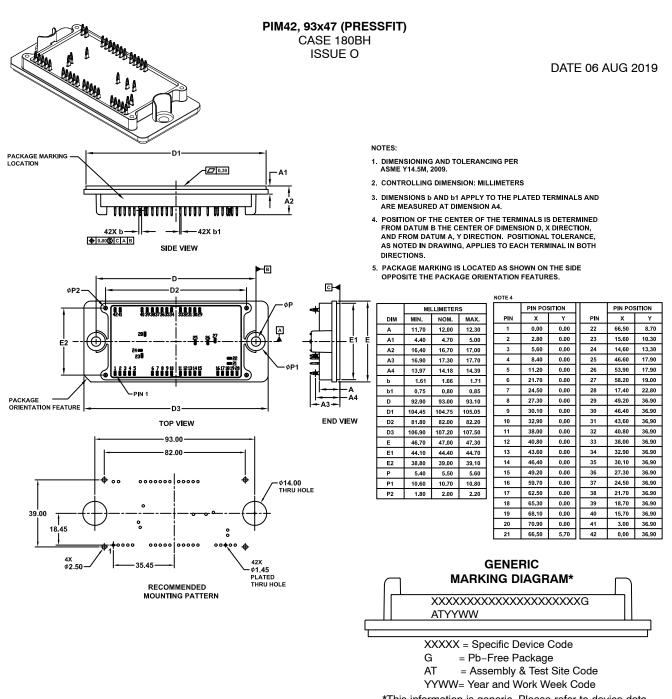


TYPICAL CHARCTERISTICS – THERMISTOR

Figure 53. Thermistor Characteristics

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS





*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ISSUE O DATE 03 DEC 2019 NOTES: PACKAGE MARKING 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. LOCATION **D** 0.30 A1 2. CONTROLLING DIMENSION: MILLIMETERS 3. DIMENSIONS & AND & 1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4 4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH 42X b DIRECTIONS 0.80**S** A B 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE SIDE VIEW OPPOSITE THE PACKAGE ORIENTATION FEATURES. −В MULIMETERS DIM MIN. NOM. MAX. D2 ØP2 11.70 12.00 12.30 Α 4.40 4.70 5.00 A1 ö 4241 40 39 38 37 36 35 34 333231 3029 A2 16.40 16.70 17.00 А3 16.80 17.20 17.60 Α 28**0** b 0.95 1.00 1.05 26 27 **F1** E E2 + (+ D 92,90 93.00 93,10 24 O 230 D1 104.45 104.75 105.05 0 22 0 21 16 17 18 19 2 ØP1 D2 81.80 82.00 82.20 6 7 8 9 10 11 12 13 14 15 D3 107.20 107.50 106.90 Е 46.70 47.00 47.30 Α PIN 1 E1 44.10 44.40 44.70 A3 D3 F2 38.80 39.00 39.10 PACKAGE Р 5.40 5.50 5.60 END VIEW TOP VIEW **ORIENTATION FEATURE** P1 10.60 10.70 10.80 NOTE 4 P2 1.80 2.00 2.20 PIN POSITION PIN POSITION PIN х Y PIN х Y 1 0.00 0.00 22 66.50 8,70 2 2.80 0,00 23 15.60 10.30 3 5.60 0.00 24 14.60 13.30 8.40 0.00 25 46.60 17.90 4 11.20 0.00 26 53.90 17.90 5 21.70 27 6 0,00 58,20 19,00 7 24.50 0.00 28 17.40 22.80 GENERIC 8 27.30 0,00 29 49.20 36,90 **MARKING DIAGRAM*** 9 30.10 0.00 30 46.40 36.90 XXXXXXXXXXXXXXXXXXXXXXXXXXXX 10 32,90 0,00 31 43,60 36,90 ATYYWW 11 38.00 0.00 32 40.80 36,90 12 40.80 0.00 33 38.00 36.90 XXXXX = Specific Device Code 13 43.60 0.00 34 32.90 36.90 G = Pb-Free Package 14 46.40 0,00 35 30.10 36,90 = Assembly & Test Site Code 15 49.20 0.00 36 27.30 36.90 AT YYWW= Year and Work Week Code 16 59.70 37 24.50 36.90 0.00 17 62.50 0.00 38 36.90 21.70 *This information is generic. Please refer to device data 18 39 65.30 0.00 18.70 36.90 sheet for actual part marking. Pb-Free indicator, "G" or 19 68.10 0.00 40 15.70 36.90 microdot "•", may or may not be present. Some products may not follow the Generic Marking. 20 70.90 0.00 41 3.00 36.90 21 66.50 5.70 42 0.00 36.90 Electronic versions are uncontrolled except when accessed directly from the Document Repository. DOCUMENT NUMBER: 98AON15232H Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** PIM42 93X47 (SOLDER PIN) PAGE 1 OF 1 ON Semiconductor and unarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding

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